# MSKSEMI 美森科













ESD

T١

TSS

MOV

GDT

PIFD

2SK3018T106(MS)

Product specification





#### **Features**

- $30V,300mA, RDS(ON) = 1\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

## **Application**

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
30V	1Ω	300mA

#### **Reference News**

PACKAGE OUTLINE	Pin Configuration	Marking
SOT-323	G	KN

# **Absolute Maximum Ratings** (TA=25 $^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
L	Drain Current – Continuous (T <sub>A</sub> =25°C)	300	mA
ID	Drain Current – Continuous (T <sub>A</sub> =70°C)	240	mA
Іом	Drain Current – Pulsed¹	1.2	Α
Б	Power Dissipation (Tc=25°C)	200	mW
Po	Power Dissipation – Derate above 25°C	2.5	mW/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 125	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Rеja	Thermal Resistance Junction to ambient		400	°C/W



## **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Parameter Conditions		Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	30			V
△BV <sub>DSS</sub> /△T <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.05		V/°C
Ipss	Drain-Source Leakage Current	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , T <sub>J</sub> =50°C			100	nA
IDSS	_	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , T <sub>J</sub> =85°C			400	nA
lgss	Gate-Source Leakage Current	V <sub>GS</sub> = ±20V , V <sub>DS</sub> =0V			±6	uA

#### **On Characteristics**

Rds(on)	Static Drain-Source On-Resistance	Vgs=10V , Ip=0.3A		1.0	3	Ω
T (DO(ON)	Statis Brain Course on Neosbarios	Vgs=4.5V , Ip=0.2A		1.3	4	12
V <sub>GS</sub> (th)	Gate Threshold Voltage	Vgs=Vps . Ip =250uA	0.8	1.1	1.6	V
△VGS(th)	V <sub>GS(th)</sub> Temperature Coefficient	2004/		3		mV/°C

**Dynamic and switching Characteristics** 

Ciss	Input Capacitance		 23	46	
Coss	Output Capacitance	VDS=30V , VGS=0V , F=1MHz	 16	32	pF
Crss	Reverse Transfer Capacitance		 10	20	

#### **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V,Force Current			300	mA
Isм	Pulsed Source Current	, , , , , , , , , , , , , , , , , , , ,			600	mA
VsD	Diode Forward Voltage	Vgs=0V , Is=0.2A , T <sub>J</sub> =25°C			1.2	V

#### Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq 300$ us , duty cycle  $\leq 2\%$ .
- 3. Essentially independent of operating temperature.

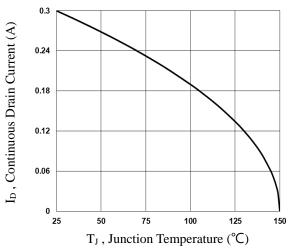


Fig.1 Continuous Drain Current vs.  $T_c$ 

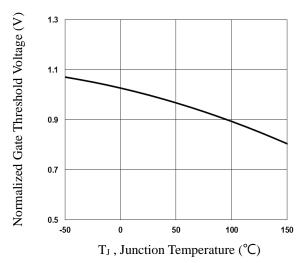


Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

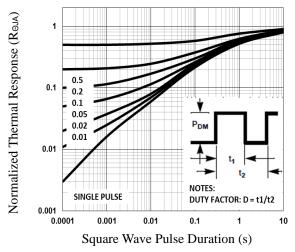


Fig.5 Normalized Transient Response

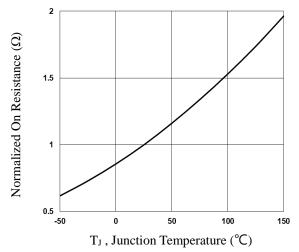
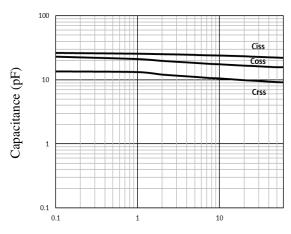


Fig.2 Normalized RDSON vs. TJ



V<sub>DS</sub>, Drain to Source Voltage

Fig.4 Capacitance Characteristics

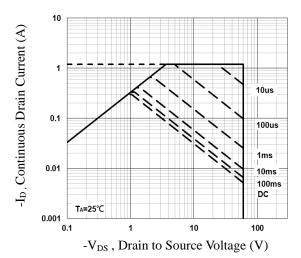
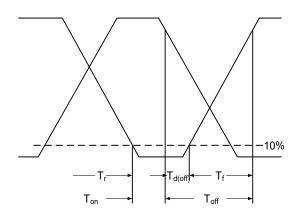


Fig.6 Maximum Safe Operation Area





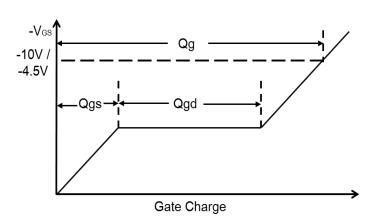
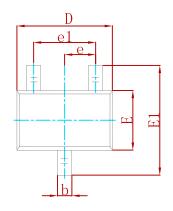
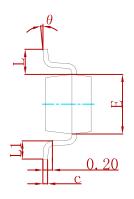


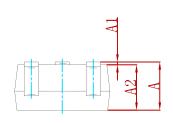
Fig.8 Gate Charge Waveform



#### **PACKAGE MECHANICAL DATA**

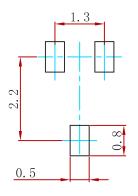






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.100	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.200	0.400	0.008	0.016
С	0.080	0.150	0.003	0.006
D	2.000	2.200	0.079	0.087
E	1.150	1.350	0.045	0.053
E1	2.150	2.450	0.085	0.096
е	0.650	) TYP	0.026	6 TYP
e1	1.200	1.400	0.047	0.055
L	0.525 REF		0.021	I REF
L1	0.260	0.460	0.010	0.018
θ	0°	8°	0°	8°

## **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

## **REEL SPECIFICATION**

P/N	PKG	QTY
2SK3018T106(MS)	SOT-323	3000



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WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13
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